



DMT4011LSS

### **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>A</sub> = +25°C
401/	11.5mΩ @ V <sub>GS</sub> = 10V	10.8A
40V	17.6mΩ @ V <sub>GS</sub> = 4.5V	8.7A

# **Description and Applications**

This MOSFET is designed to minimize the on-state resistance  $(R_{DS(ON)})$ , maintain superior switching performance, making it ideal for high efficiency power management applications.

- DC-DC Converters
- Synchronous Rectification
- Power Supplies

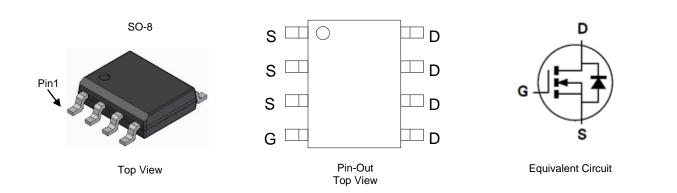
#### 40V N-CHANNEL ENHANCEMENT MODE MOSFET

### **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

## **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 <sup>(3)</sup>
- Weight: 0.076 grams (Approximate)



## Ordering Information (Note 4)

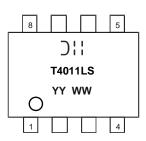
	Part Number	Case	Packaging
	DMT4011LSS-13	SO-8	2,500/Tape & Reel
Notes:	1. No purposely added lead. Fully EU Direct	tive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/	863/EU (RoHS 3) compliant.

No pulposely added lead. Fully ED Directive 2002/95/EC (ROFS), 2017/05/ED (ROFS 2) & 2015/06/ED (ROFS 3) Compliant.
See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

# **Marking Information**



)|| = Manufacturer's Marking T4011LS = Product Type Marking Code YYWW = Date Code Marking YY or  $\overline{YY}$  = Year (ex: 19 = 2019) WW or  $\underline{WW}$  = Week (01 to 53)



# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage	V <sub>DSS</sub>	40	V	
Gate-Source Voltage	V <sub>GSS</sub>	±20	V	
Continuous Drain Current, V <sub>GS</sub> = 10V (Note 6)	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	Ι <sub>D</sub>	10.8 8.67	А
Continuous Drain Current, $V_{GS} = 10V$ (Note 5) $T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$		Ι <sub>D</sub>	8.7 6.9	А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	IDM	70	A	
Maximum Continuous Body Diode Forward Current (Note	Is	2.4	A	
Avalanche Current, L = 0.1mH		I <sub>AS</sub>	19.9	А
Avalanche Energy, L = 0.1mH	E <sub>AS</sub>	19.8	mJ	

# Thermal Characteristics ( $@T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)	PD	1.31	W	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	R <sub>0JA</sub>	95.4	°C/W
Total Power Dissipation (Note 6)	·	PD	2.02	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	R <sub>0JA</sub>	61.7	°C/W
Thermal Resistance, Junction to Case	·	R <sub>0JC</sub>	9.3	°C/W
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

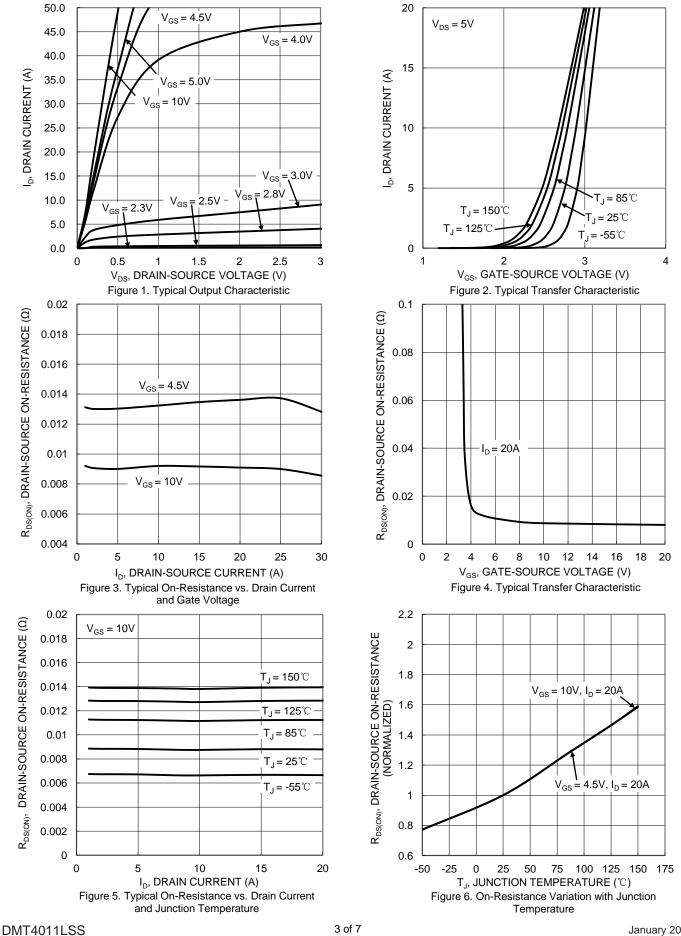
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)				1			
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	40	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	IDSS	_	_	1	μA	$V_{DS} = 32V, V_{GS} = 0V$	
Gate-Source Leakage	laas	_	_	+100 -100	nA	$V_{GS} = +20V, V_{DS} = 0V$	
Gale-Source Leakage	I <sub>GSS</sub>					$V_{GS} = -16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1.1	1.7	2.4	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance			8.5	11.5	mΩ	$V_{GS} = 10V, I_D = 20A$	
	R <sub>DS(ON)</sub>		12.8	17.6	11152	$V_{GS} = 4.5V, I_D = 20A$	
Diode Forward Voltage	V <sub>SD</sub>	_	0.84	1.2	V	$V_{GS} = 0V, I_{S} = 20A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss		829	_		$V_{DS} = 20V, V_{GS} = 0V,$ f = 1MHz	
Output Capacitance	C <sub>oss</sub>	_	248	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>		24.6	—			
Gate Resistance	R <sub>G</sub>		2.0		Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_{G}$		14.3	—		$V_{DS}$ = 20V, $I_D$ = 20A	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_G$		7.2	—	nC		
Gate-Source Charge	Q <sub>GS</sub>	_	1.7	_	nc		
Gate-Drain Charge	Q <sub>GD</sub>		3.0	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	-	4.4	_		$V_{GS}$ = 10V, $V_{DS}$ = 20V, R <sub>G</sub> = 1.6 $\Omega$ , I <sub>D</sub> = 20A	
Turn-On Rise Time	t <sub>R</sub>	_	3.7	_			
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	13.5	_	ns		
Turn-Off Fall Time	t <sub>F</sub>	-	3.3	—			
Reverse Recovery Time	t <sub>RR</sub>		11.9	_	ns	1- 154 di/dt 1004/wa	
Reverse Recovery Charge	Q <sub>RR</sub>		9.4		nC	I <sub>F</sub> = 15A, di/dt = 400A/μs	

Notes:

Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1-inch square copper plate.
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing.







Document number: DS41355 Rev. 2 - 2



### DMT4011LSS

100 125 150 175

f = 1MHz

 $I_D = 1mA$ 

75

20

 $P_W = 1s$ 

∄

10

P<sub>W</sub> = 10s

25

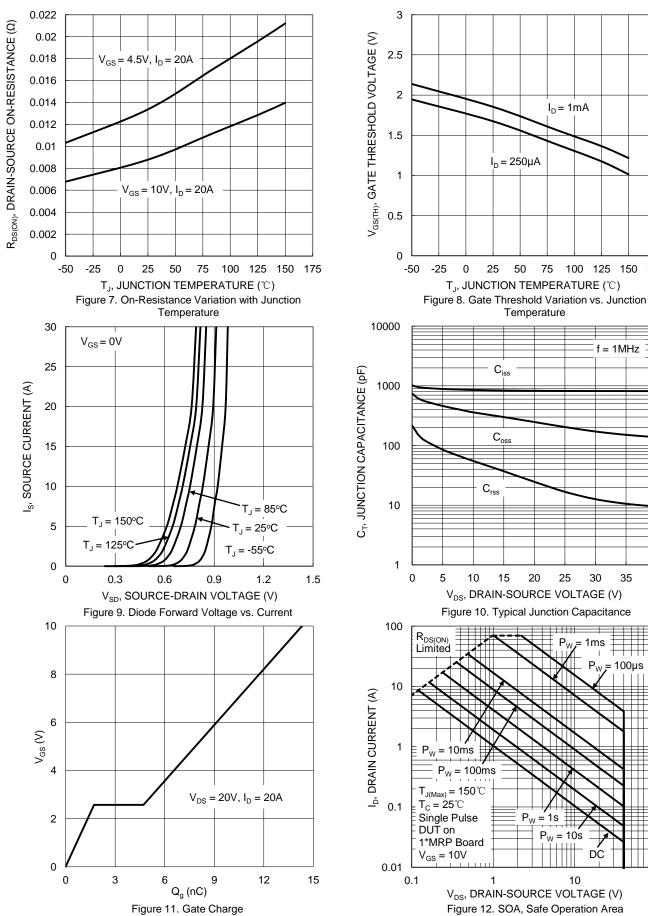
30

1ms

35

100µs

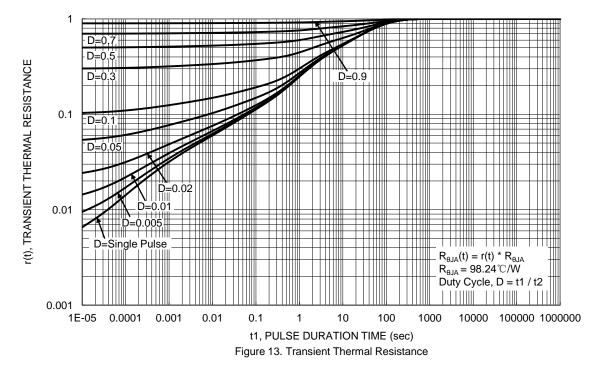
40



DC

100



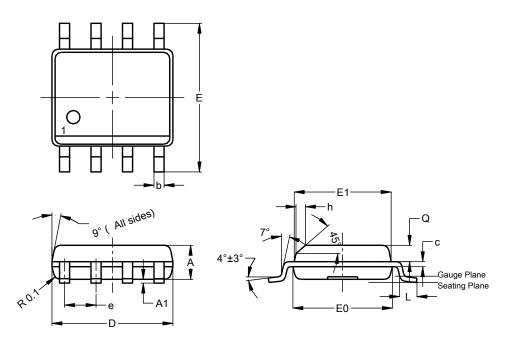




# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-8

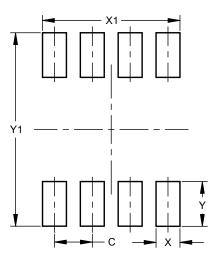


SO-8					
Dim	Min	Max	Тур		
Α	1.40	1.50	1.45		
A1	0.10	0.20	0.15		
b	0.30	0.50	0.40		
c	0.15	0.25	0.20		
D	4.85	4.95	4.90		
E	5.90	6.10	6.00		
E1	3.80	3.90	3.85		
E0	3.85	3.95	3.90		
e			1.27		
h	-		0.35		
L	0.62	0.82	0.72		
Q	0.60	0.70	0.65		
All Dimensions in mm					

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-8



Dimensions	Value (in mm)			
С	1.27			
Х	0.802			
X1	4.612			
Y	1.505			
Y1	6.50			



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